

Noise enhanced transport in nanoelectronic devices

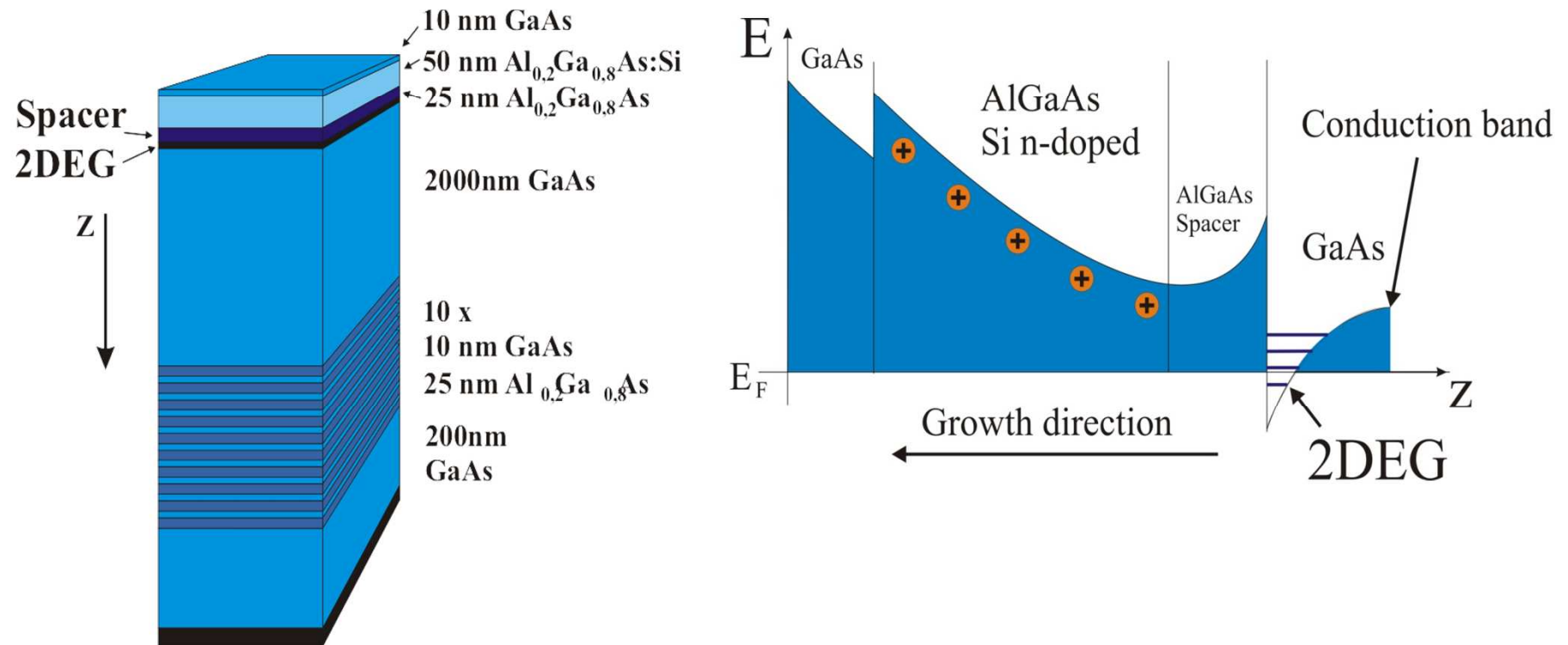
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Systems*

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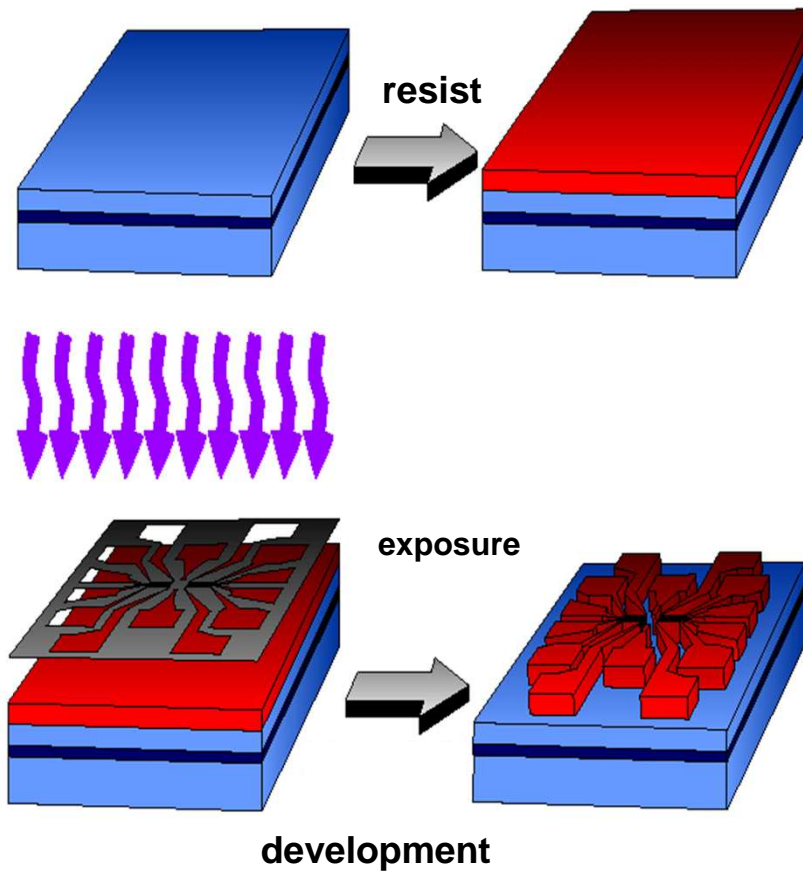
- Technology & working principle
 - 2-DEG: Growth and fabrication
 - Y-branch junction and resonant tunneling diode (RTDs)
- Noise enhanced transport in Y-branch junctions
 - Stochastic resonance at 1Hz
 - Nonlinear noise activated magnetic field sensor
- Universal logic gate switching in RTDs
 - Universal logic gate switching from NOR to NAND
 - Logic stochastic resonance (LSR)

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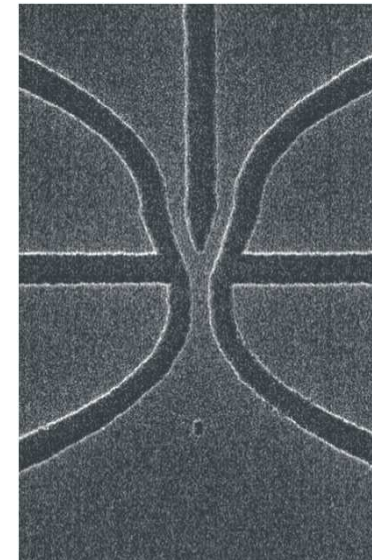


❑ Modulation doped GaAs/AlGaAs heterostructure (HEMT)

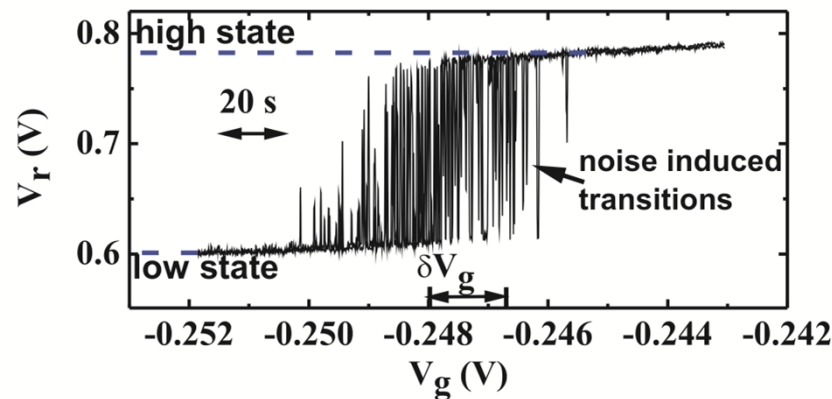
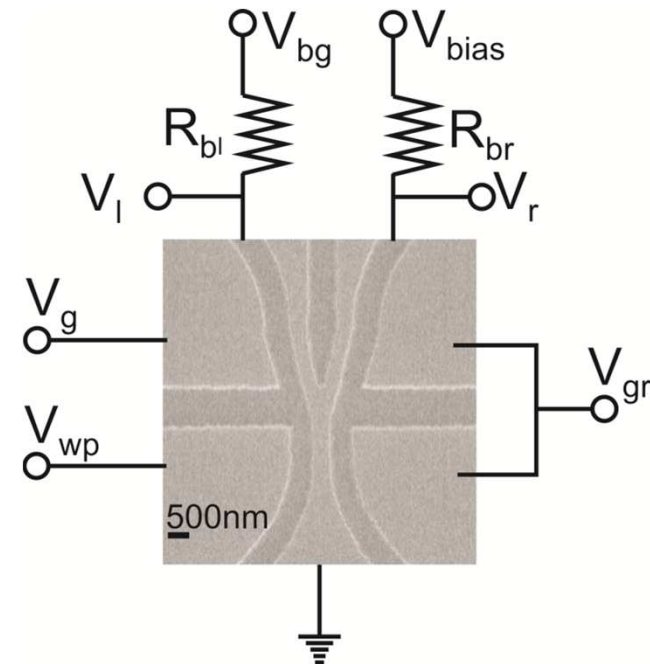
❑ High mobility $\mu = 1.1 \cdot 10^6 \text{ cm}^2/\text{Vs}$ and charge density $n = 3.7 \cdot 10^{11} \text{ cm}^{-2}$



- Electron beam lithography
- Dry chemical etching was applied to define the Y-branch structure



- the input and the working point voltages set the condition of the Y-branch switch
- self-gating leads to a bistable transfer characteristic
- noise induced oscillations occur
- all measurements @ 20K

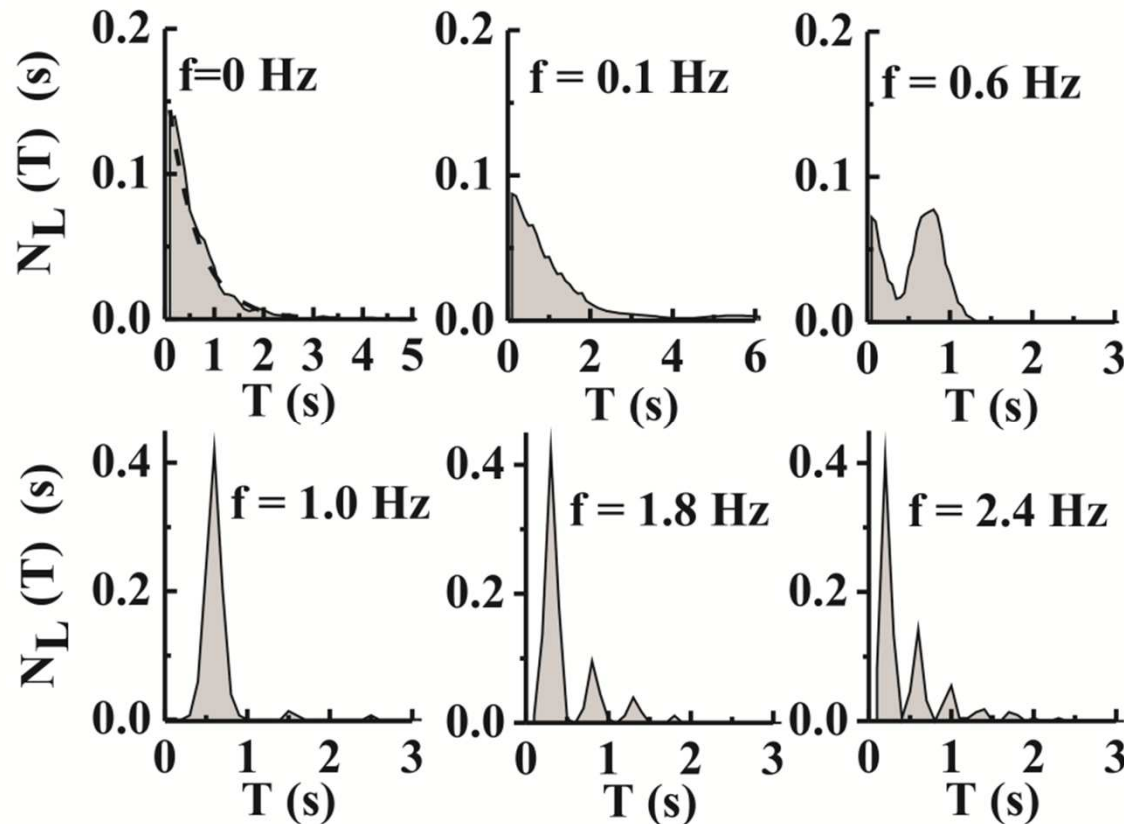


Input signal:

$$V_g(t) = V_{g,0} + \delta V_g \cdot \sin(\omega t)$$

Weak periodic signal:

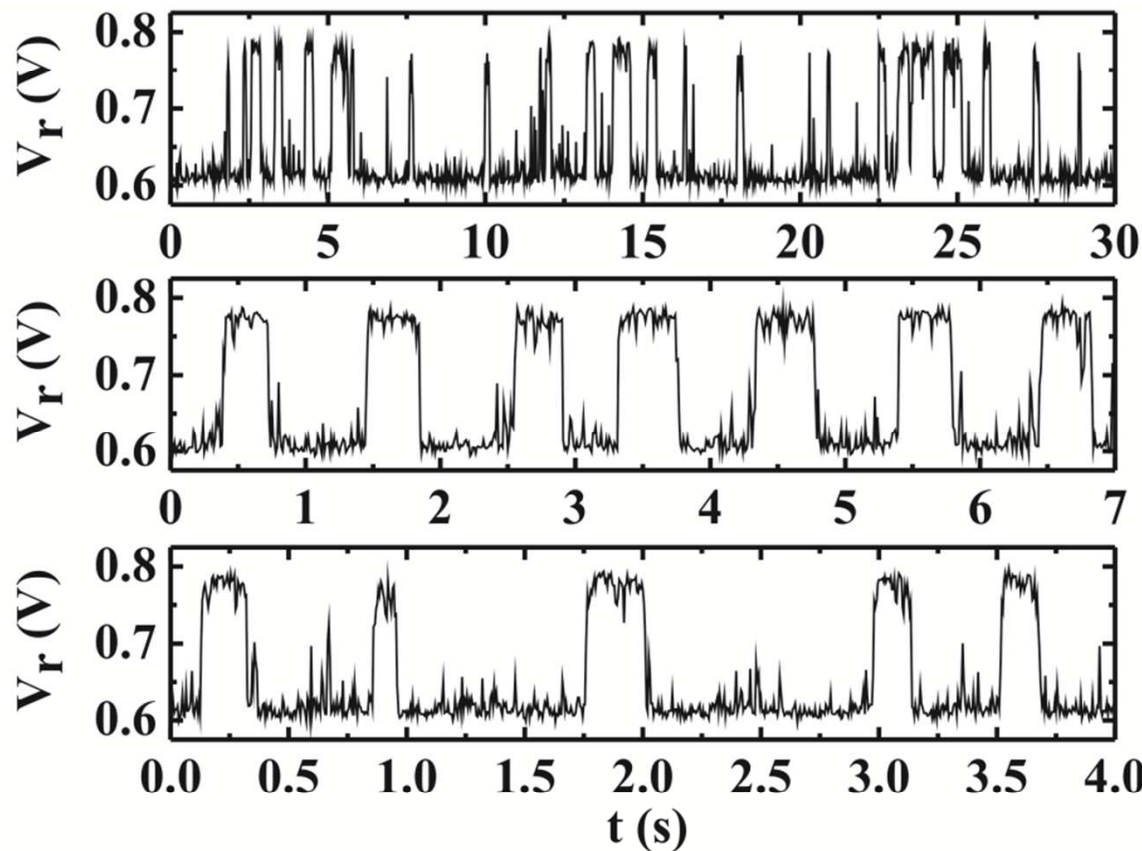
$$\delta V_g = 1.3 \text{ mV}$$



- For $f < f_{SR}$ the residence time distribution is strongly controlled by the noise
- For $f > f_{SR}$ odd multiples of the periodic forcing T_ω occur:

$$T_n = (2n - 1)T_\omega / 2$$

At the optimum frequency $f = 1$ Hz the residence time distribution is almost perfectly restricted to the first peak.

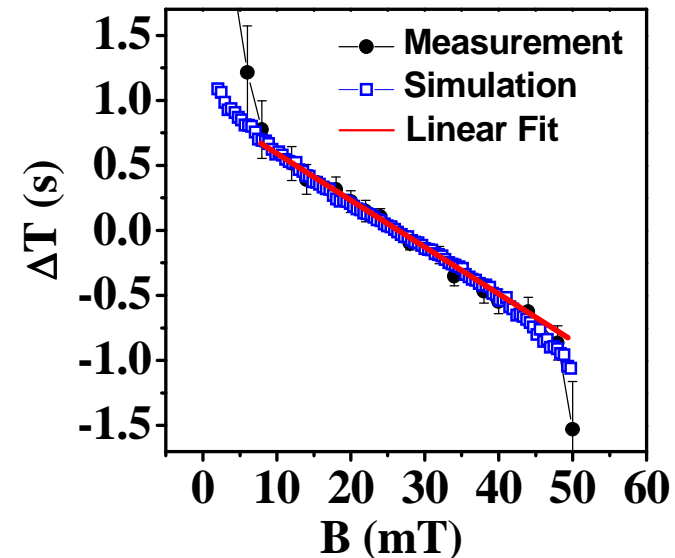
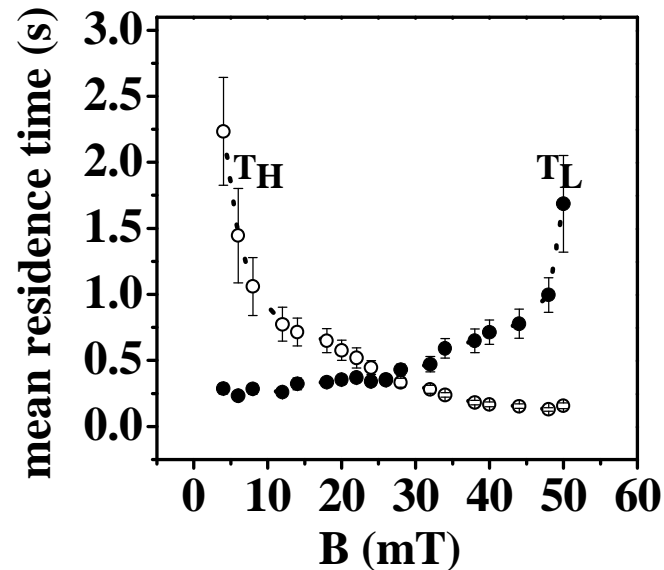


$f = 0.1$ Hz

$f = 1$ Hz

$f = 1.8$ Hz

At $f = 1$ Hz the noise dynamics follow directly the frequency of the external input forcing and a maximum synchronization is found.



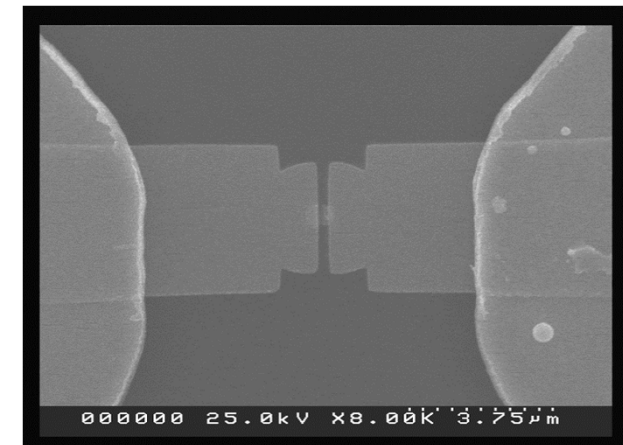
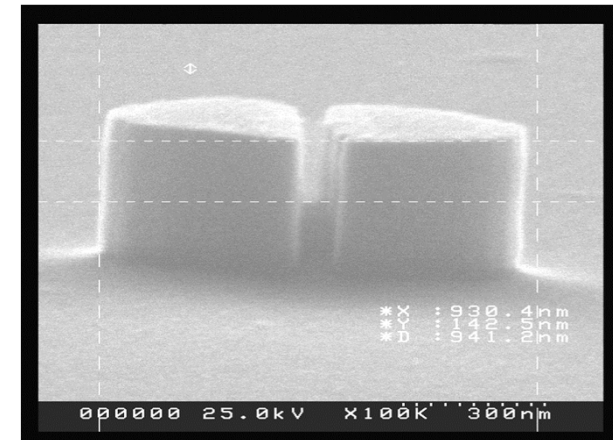
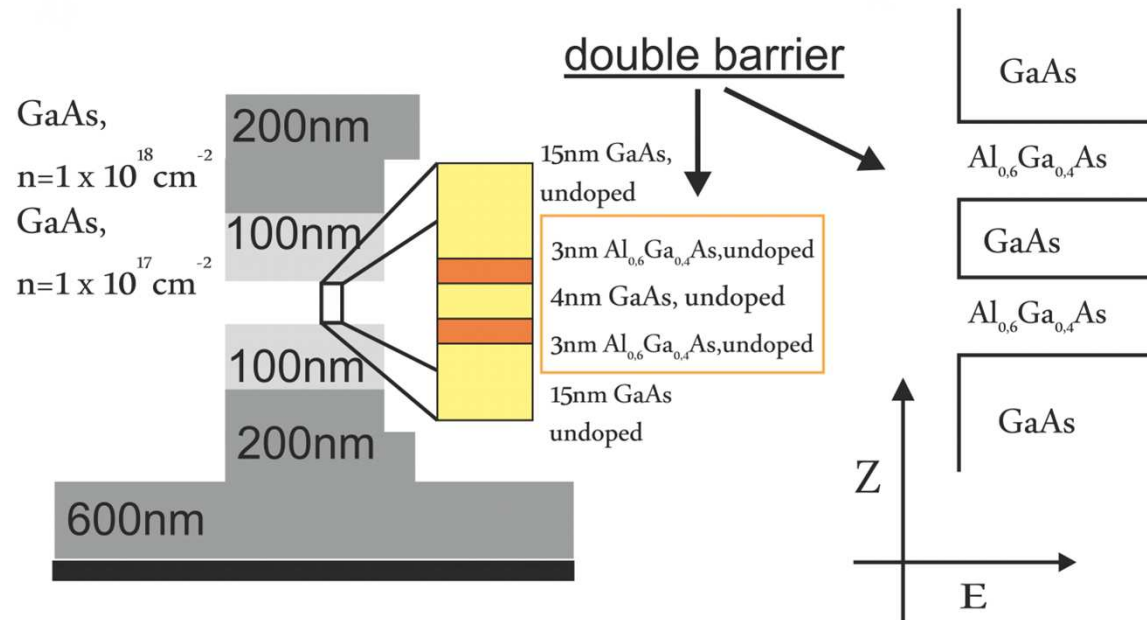
- Output is a linear function of B around $\Delta T = 0$ s
- Target signal independent sensitivity

$$\Delta T(B) = T_0 - cB$$

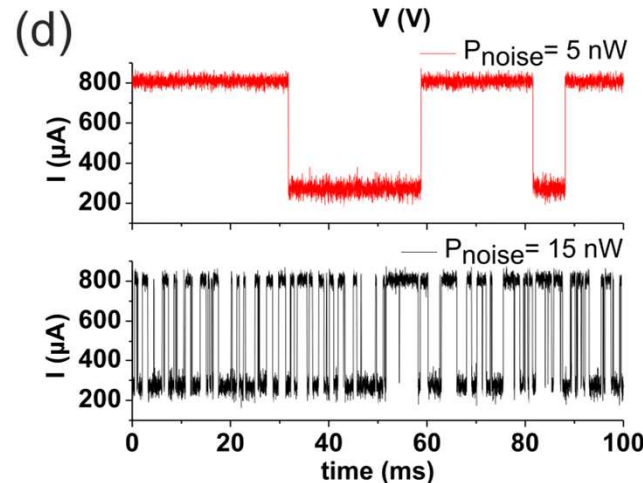
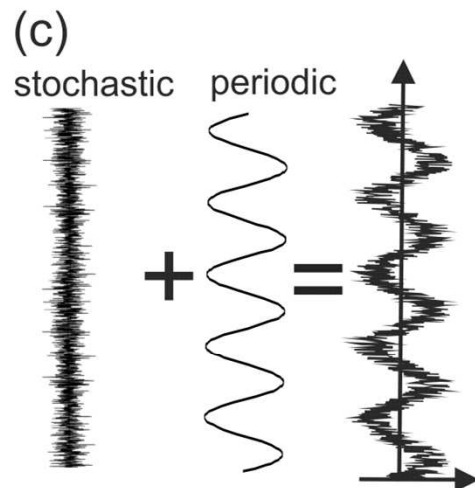
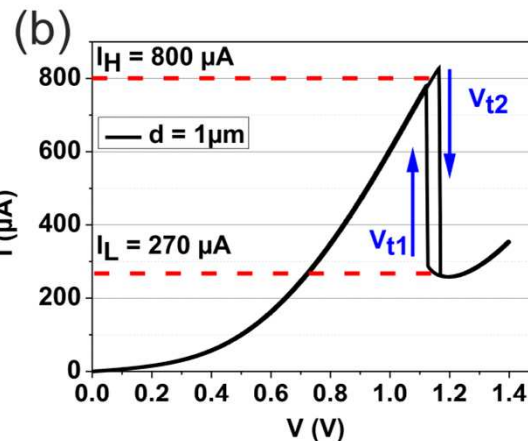
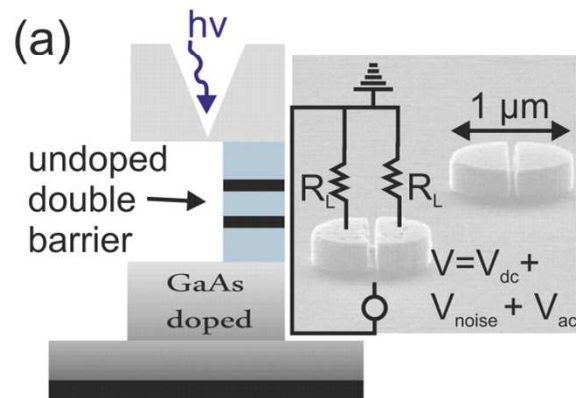
$$S(B) = \frac{\partial \Delta T}{\partial B} = c$$

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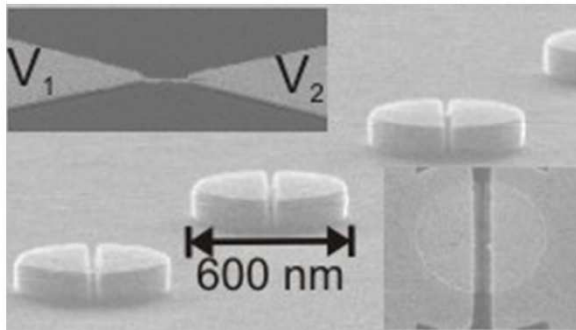
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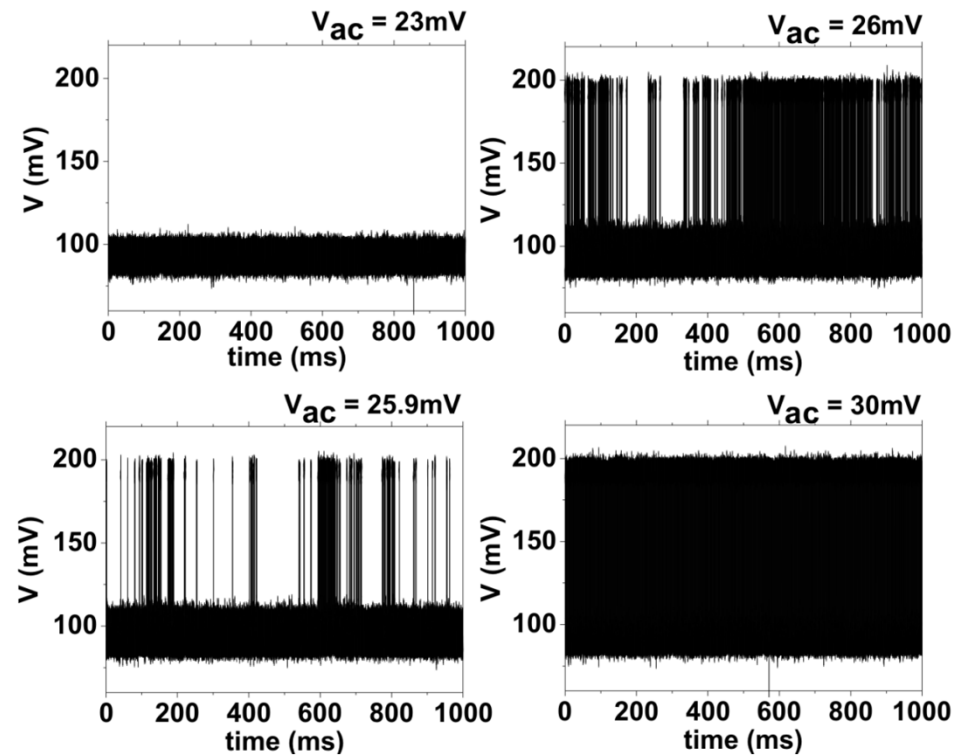
- RTDs AlGaAs/GaAs/AlGaAs DBS
- Dry chemical etching to define mesa from 1 μm down to 50 nm
- BCB (polymer) for mesa isolation
- Top Au/Ti/Ni contact

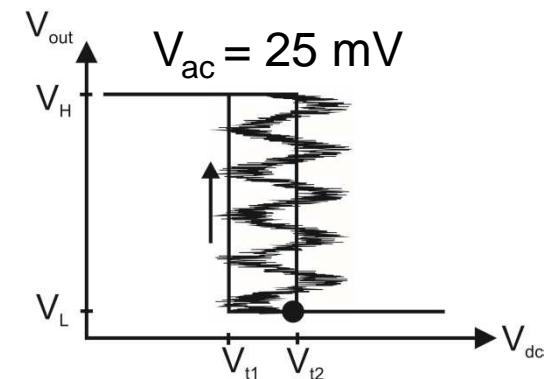
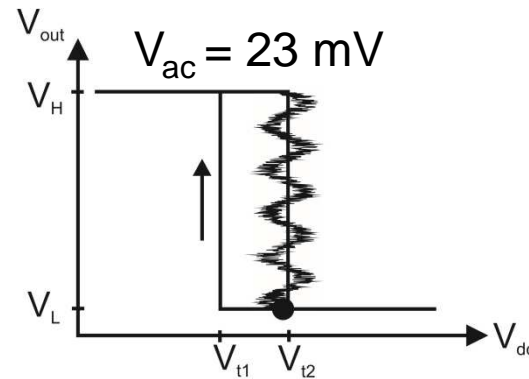
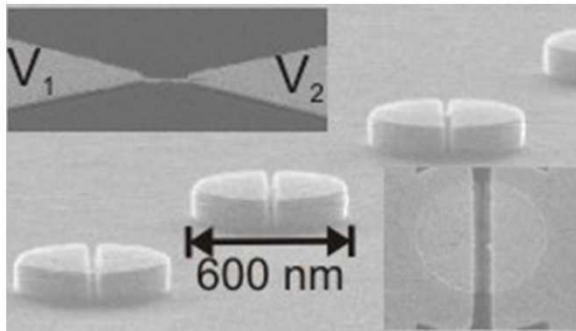


- RTD is bistable with stable outputs $I_H = 800 \mu\text{A}$ and $I_L = 270 \mu\text{A}$
- Works @ RT
- PVR ~ 3
- Noise induced switching from one stable state appear
- Time scale is given by the inverse of the Kramer's rate

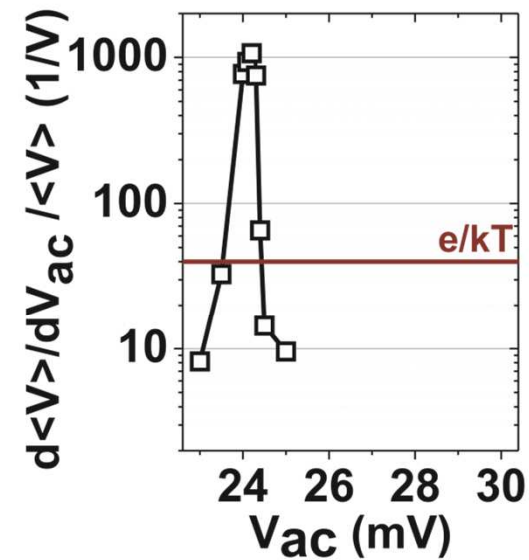
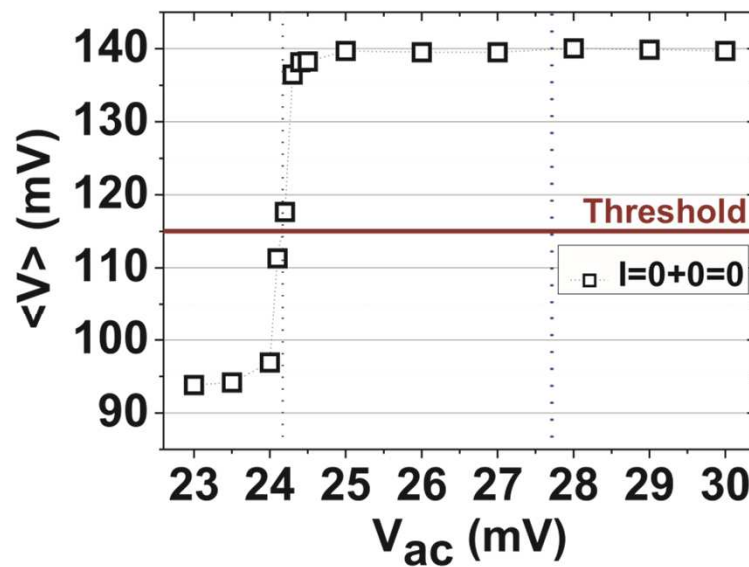


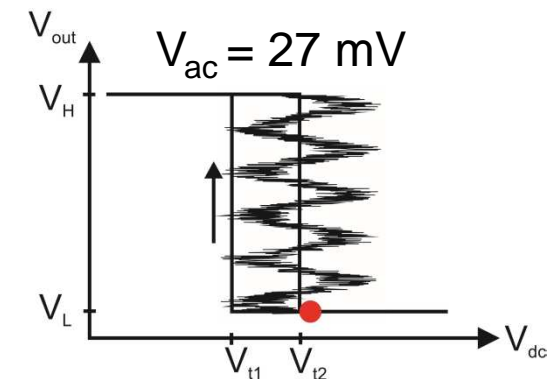
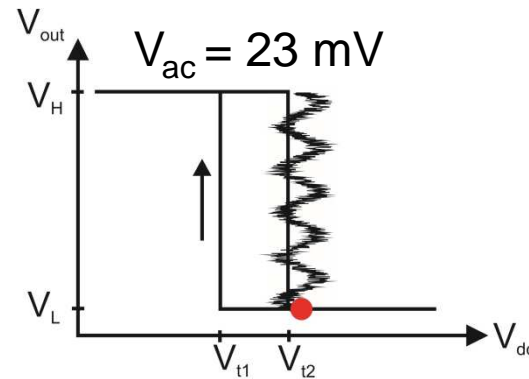
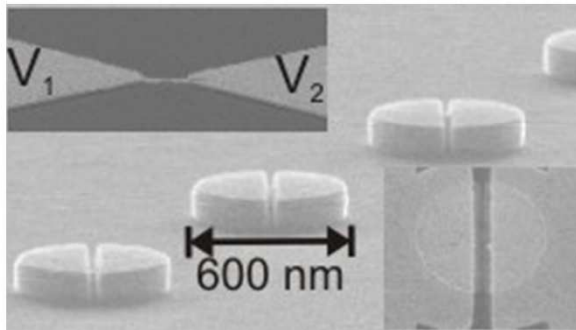
- ☐ Noise induced signal trains
- ☐ Mean value is efficiently controlled by input signals
- ☐ Can be integrated to arrays
- ☐ No classical kT limit of transconductance



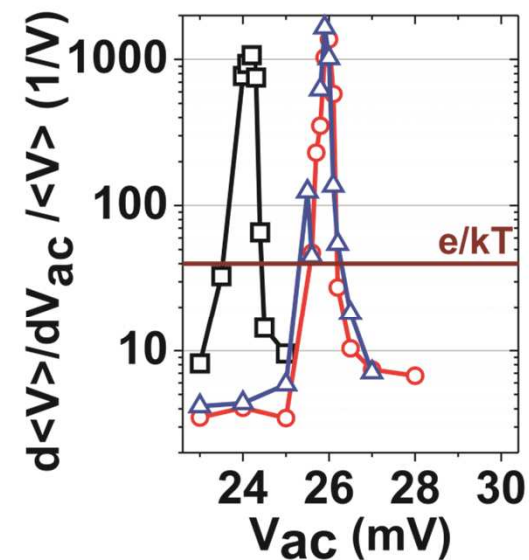
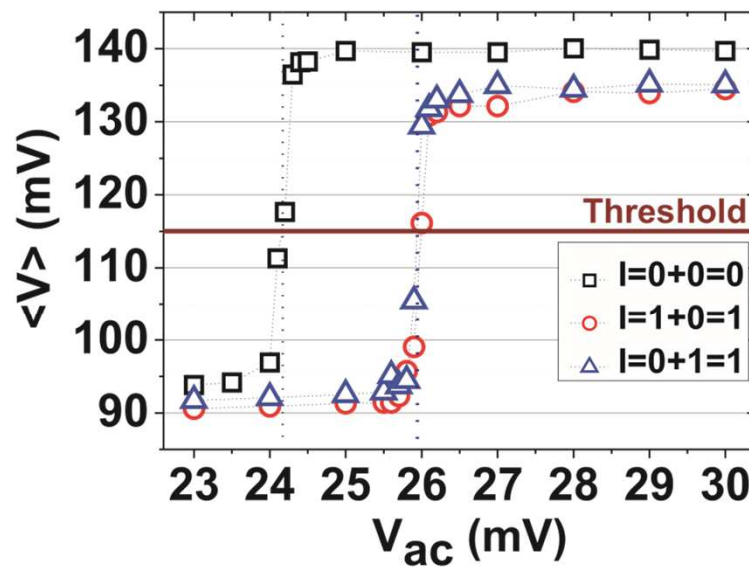


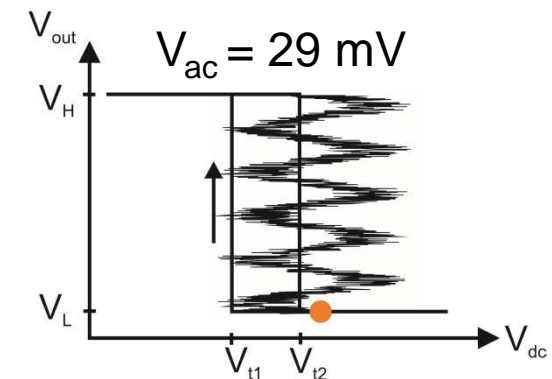
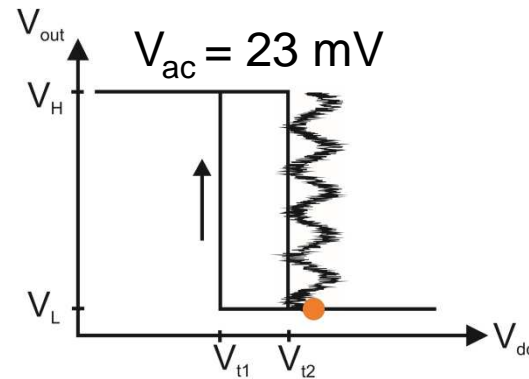
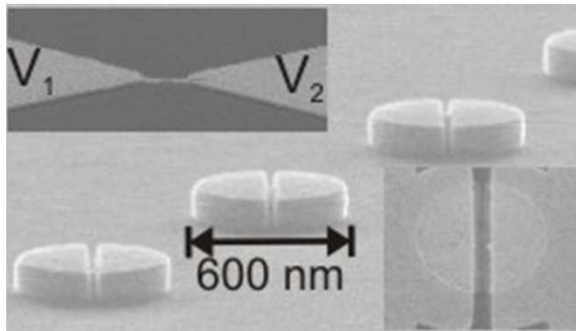
Switching voltages: $V_1 = V_2 = 0 \text{ mV}$



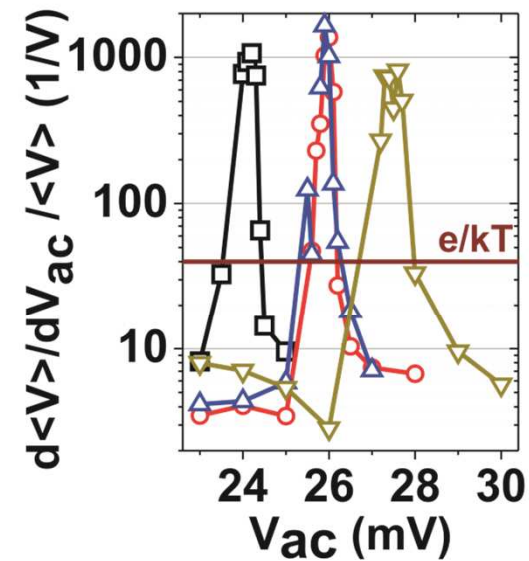
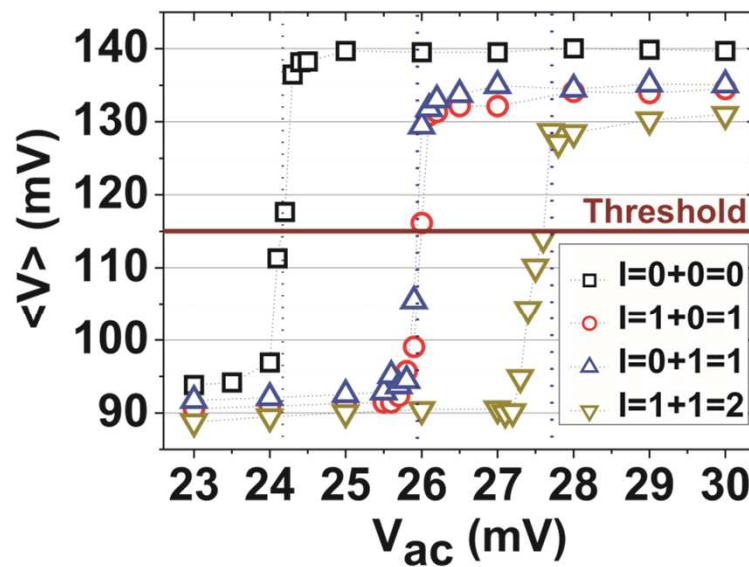


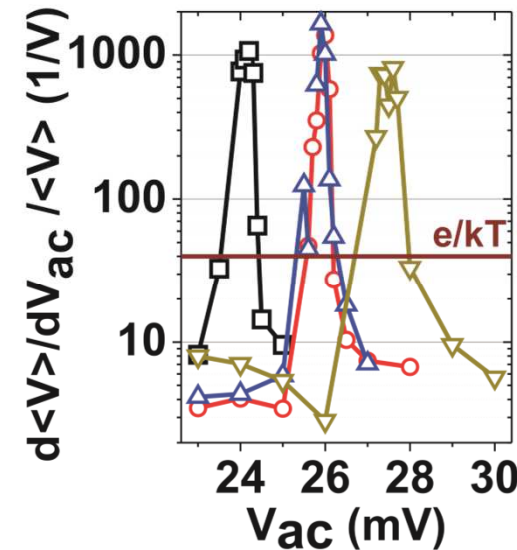
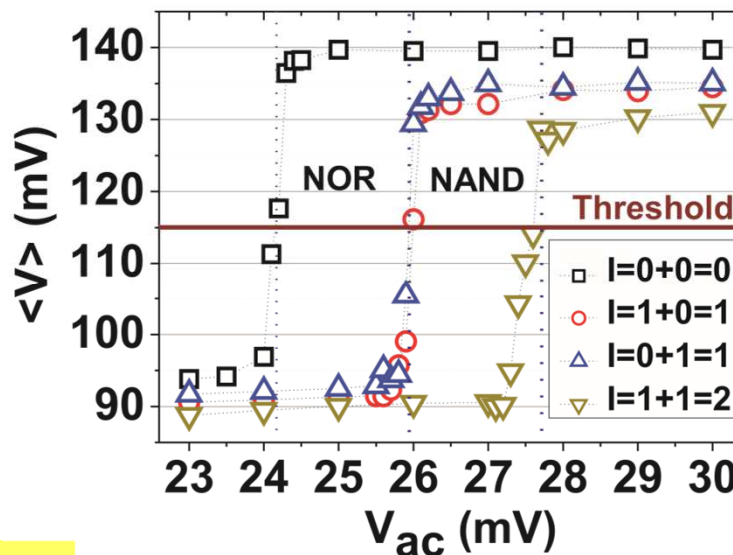
Switching voltages: $V_1 = 0, 2 \text{ mV}$ $V_2 = 2, 0 \text{ mV}$





Switching voltages: $V_1 = V_2 = 2$ mV





NOR

0	0		1
1	0		0
0	1		0
1	1		0



NAND

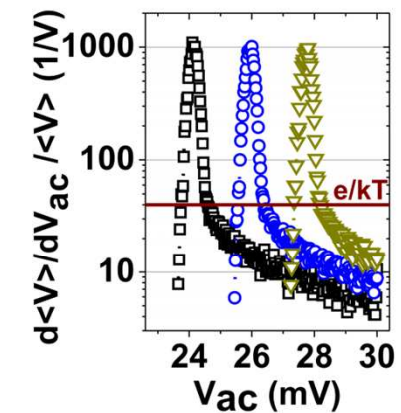
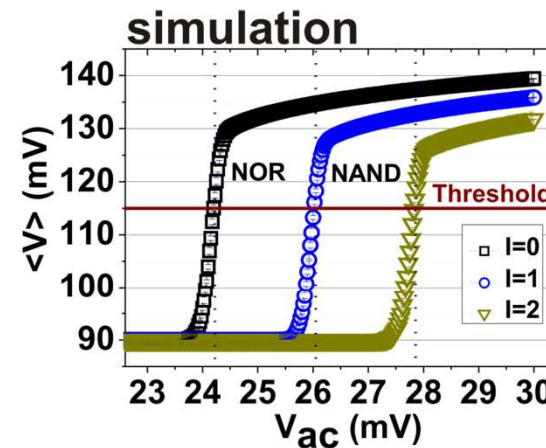
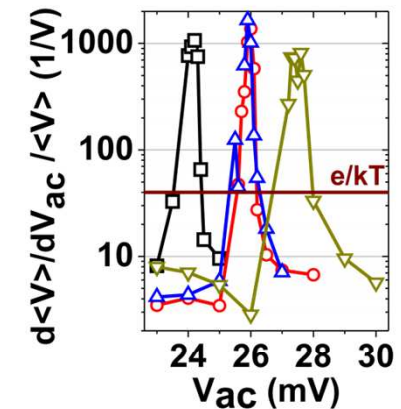
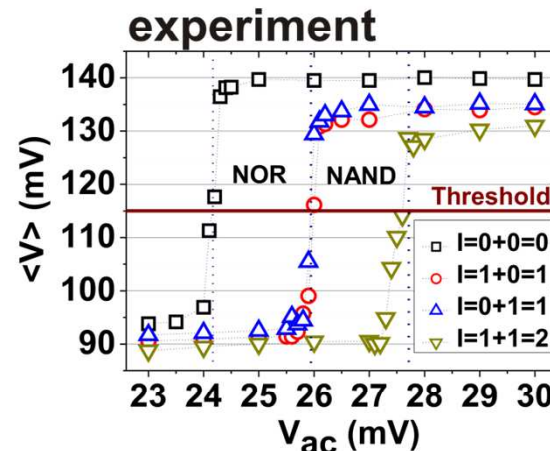
0	0		1
1	0		1
0	1		1
1	1		0

□ Switch from NOR to NAND for $\Delta V_{ac} < 1$ mV
with a logic input voltage 2 mV

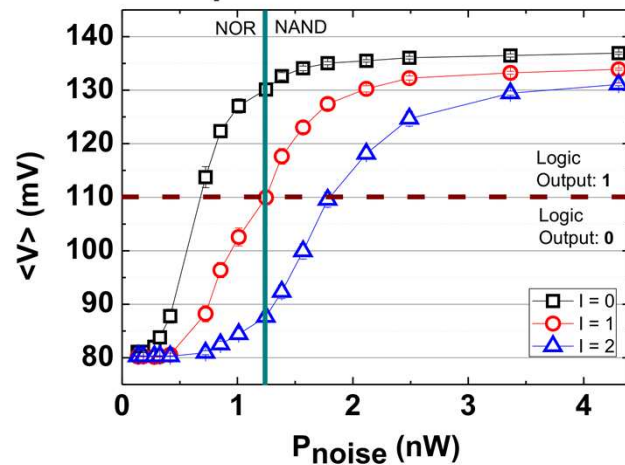
- ☐ Schmitt-Trigger simulation
- ☐ All Parameters from the experiment
- ☐ Excellent agreement !!

Parameter:

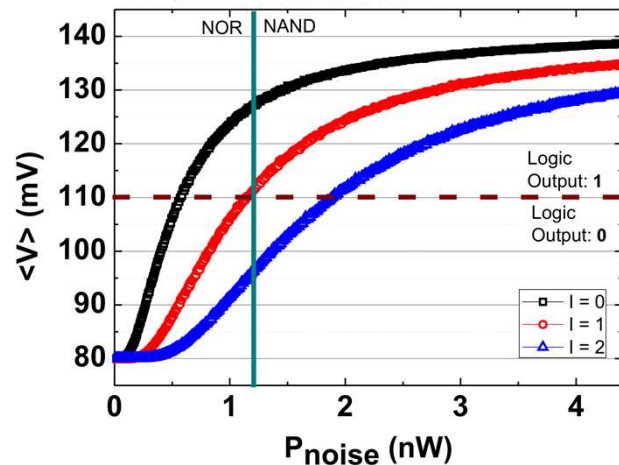
- $b = 15 \text{ mV}$
- $f = 1 \text{ kHz}$
- $\Delta T = 50 \text{ ms}$
- $\Delta x = 2 \text{ mV}$



experiment

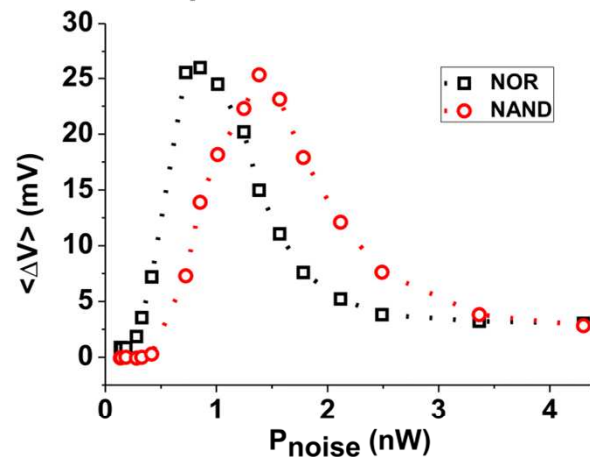


simulation



- Universal logic gate switching solely controlled by noise.
- Two universal logic gates: NOR/NAND
- Switching between the gates only as a function of noise power.

experiment



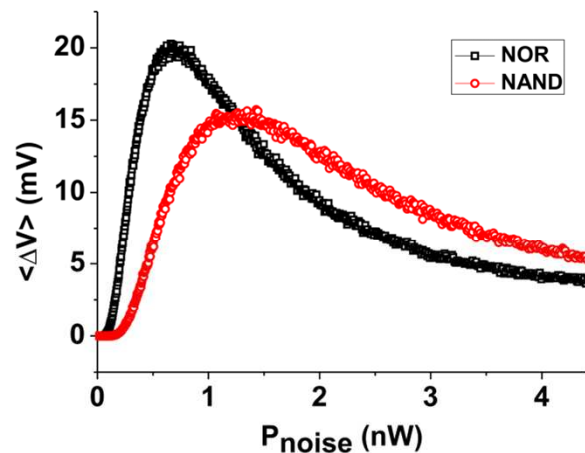
- For the logic NOR gate:

The mean value difference is defined as

$$\langle V \rangle = V(I=0) - V(I=1)$$

$P_{\text{noise}} = 0.9$ nW the maximum corresponds to the logic NOR

simulation



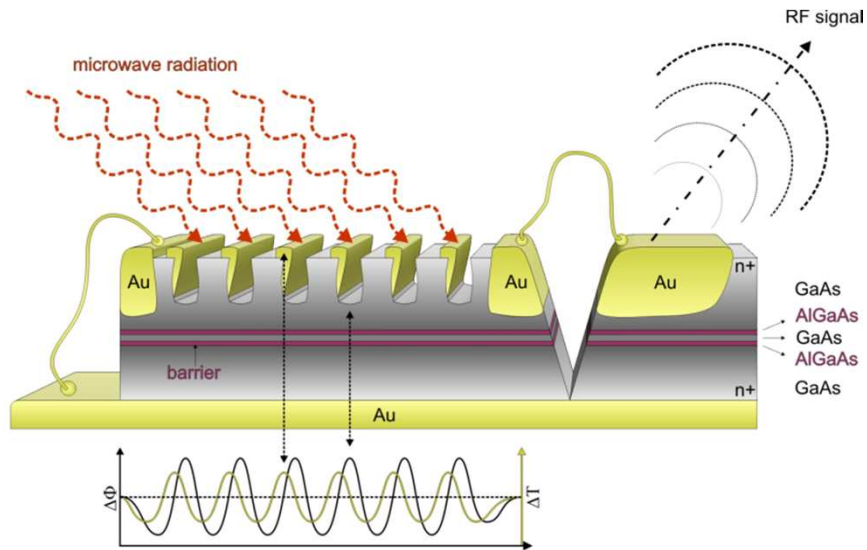
- For the logic NAND gate:

The mean value difference is defined as

$$\langle V \rangle = V(I=1) - V(I=2)$$

$P_{\text{noise}} = 1.4$ nW the maximum corresponds to the logic NAND

- **Noise enhanced transport in Y-branch junctions**
 - Bistable transfer characteristic due to self-gating with noise activated switching
 - Synchronization of the internal noise floor with a weak periodic signal at 1 Hz: Stochastic resonance
 - Noise activated nonlinear magnetic field sensor
- **Noise enhanced logic gate switching in RTDs**
 - Universal logic gate switching with switching voltages of only 2mV
 - Logic Stochastic resonance with nW noise powers
 - Maximum logic gate operation at different noise inputs

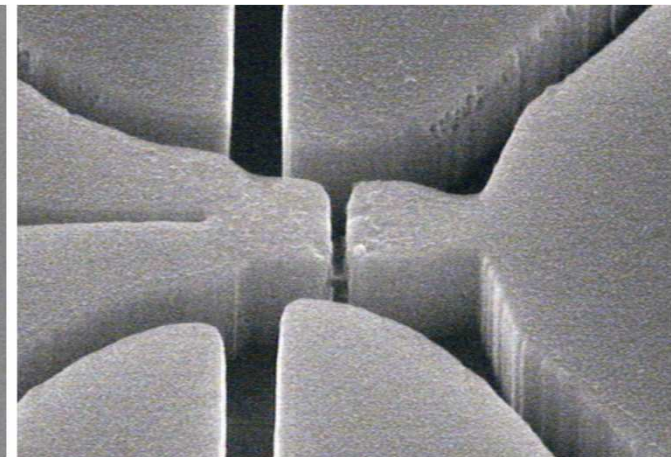
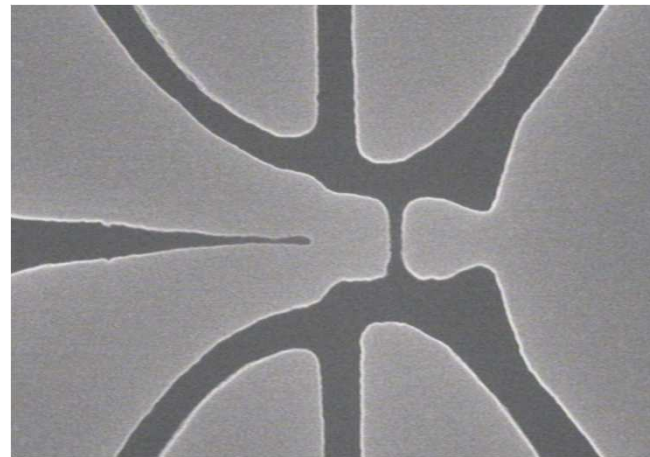


Quantum harvester 1:

- Autonomous ICT device
- Büttiker-Landauer motor

Quantum harvester 2:

- Heat to current conversion proposed by R. Sanchez and M. Büttiker



- Supported by: EU IST-SUBTLE, State of Bavaria and **NANOPOWER**

NANOPOWER

Many thanks for your attention!